

# Announcing Patent Quality Chat

Beginning Tuesday, June 9, 2015 • 12:00 pm – 1:00 pm EDT

(Monthly on the second Tuesday of the month)

Broadcast live from USPTO Headquarters • Alexandria, VA



The Deputy Commissioner for Patent Quality is pleased to announce the start of a series of events collectively entitled Patent Quality Chat, a lunchtime patent quality webinar series.

Each event will be hosted by patent quality specialist(s) for the purpose of updating you on timely themes related to patent quality where the Office currently has a particular focus.

All Patent Quality Chats will include a presentation and time for attendee questions and comments. All Patent Quality Chats are free and open to all on a first-come, first-served basis. Video recordings and any presentation materials will be posted on the Patent Quality Chat website after the event.

Date	Topic	Speaker
TUESDAY, JUNE 9	Clarity of the Record	Deputy Commissioner for Patent Examination Policy Drew Hirshfeld
TUESDAY JULY 14	Face-to-face Examiner Interviews: A Demonstration of USPTO Tools	Director of Technology Center 2400 Timothy Callahan
TUESDAY, AUGUST 11	Measuring Patent Quality	Deputy Commissioner for Patent Quality Valencia Martin Wallace
Future dates of 9/8, 10/13, 11/10 are scheduled and may include topics of Office of Patent Quality Assurance (OPQA) Processes, Compact Prosecution, and Special Programs for Patent Prosecution		

- For inquiries about Patent Quality Chats, please contact the Deputy Commissioner for Patent Quality at [DeputyCommissionerforPatentQuality@uspto.gov](mailto:DeputyCommissionerforPatentQuality@uspto.gov)

- For complete webinar participation instructions, please visit the Patent Quality Chat website.



<http://www.uspto.gov/patent/initiatives/patent-quality-chat>

- For more information about the Enhanced Patent Quality Initiative at the USPTO, please visit the EPQI website.



<http://www.uspto.gov/patent/initiatives/enhanced-patent-quality-initiative>

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